

Notice of References Cited	Application/Control No. 09/815,816	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Shefali D Patel	Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
<input checked="" type="checkbox"/>	A	US-5,446,542	08-1995	Muraoka, Yukihiro	356/400
<input checked="" type="checkbox"/>	B	US-4,886,974	12-1989	Ina, Hideki	250/559.36
<input checked="" type="checkbox"/>	C	US-6,141,464	10-2000	Handley, John C.	382/287
<input checked="" type="checkbox"/>	D	US-5,398,292	03-1995	Aoyama, Chiaki	382/199
<input checked="" type="checkbox"/>	E	US-5,400,135	03-1995	Maeda, Ichiro	356/239.1
<input checked="" type="checkbox"/>	F	US-6,606,145	08-2003	Irie et al.	355/72
<input checked="" type="checkbox"/>	G	US-6,628,406	09-2003	Kreuzer, Justin L.	356/508
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.